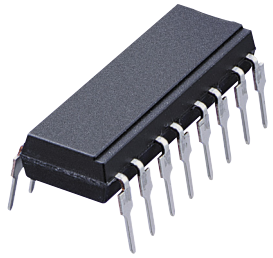
PC845XJ0000F Series

*1-channel package type is also available.
(model No. **PC815XJ0000F Series**)

DIP 16pin (4-channel) Darlington Phototransistor Output, Photocoupler



■ Description

PC845XJ0000F Series contains an IRED optically coupled to a phototransistor.

It is packaged in a 4-channel package, available in SMT gullwing lead-form option.

Input-output isolation voltage(rms) is 5.0 kV.

CTR is MIN. to 600% at input current of 1.0 mA.

■ Features

1. 6pin DIP 4-channnel package
2. Double transfer mold package (Ideal for Flow Soldering)
3. Darlington phototransistor output (CTR : MIN. 50% at I_F=1.0 mA, V_{CE}=2 V)
4. High isolation voltage between input and output ($V_{iso(rms)}$: 5.0 kV)
5. Lead-free and RoHS directive compliant

■ Agency approvals/Compliance

1. Recognized by UL1577 (Double protection isolation), file No. E64380 (as model No. **PC845**)
2. Approved by VDE, DIN EN60747-5-2(*) (as an option), file No. 40008087 (as model No. **PC845**)
3. Package resin : UL flammability grade (94V-0))

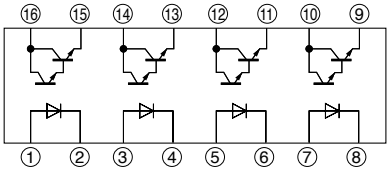
(*) DIN EN60747-5-2 : successor standard of DIN VDE0884.

■ Applications

1. Home appliances
2. Programmable controller
3. Signal transmission between circuits of different potentials and impedances

Sheet No.: D2-A08501EN
Date Sep. 1. 2006

■ Internal Connection Diagram

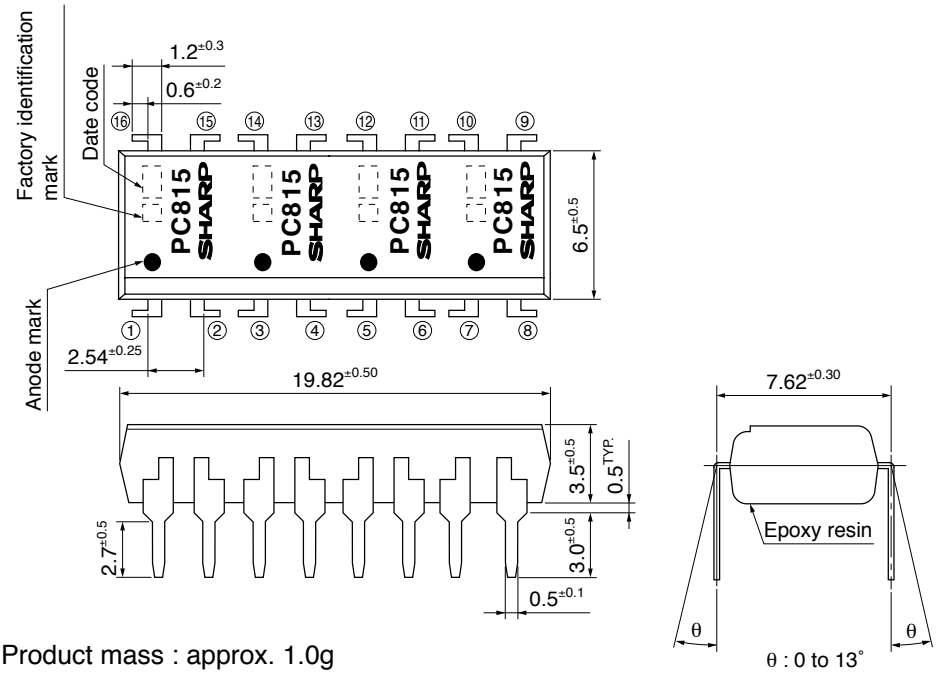


①③⑤⑦ Anode
②④⑥⑧ Cathode
⑨⑪⑬⑮ Emitter
⑩⑫⑭⑯ Collector

■ Outline Dimensions

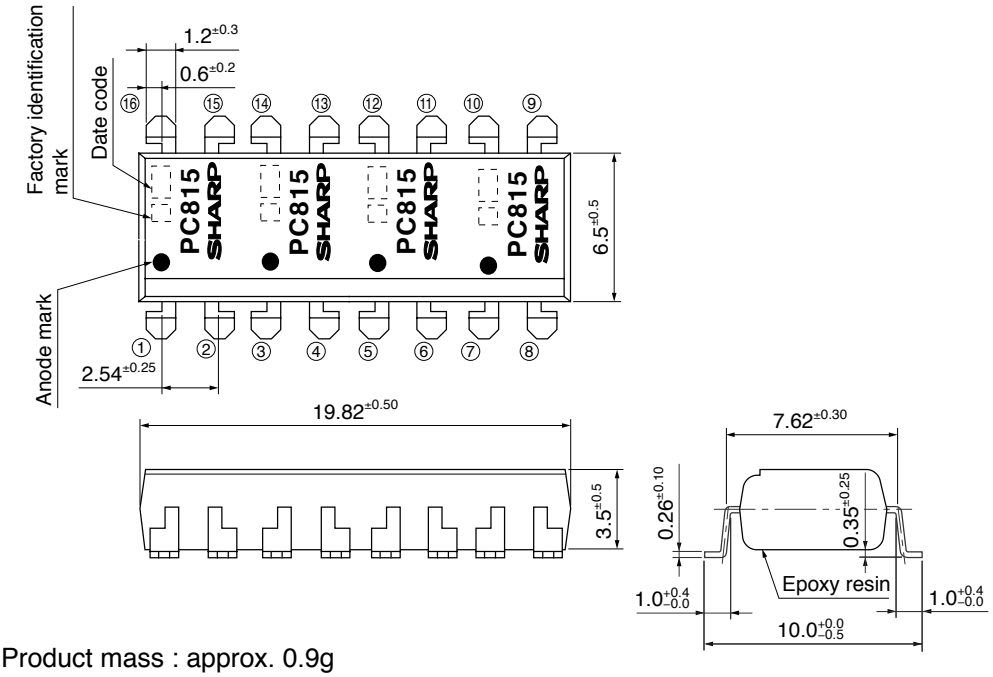
(Unit : mm)

1. Through-Hole [ex. **PC845XJ0000F**]



Product mass : approx. 1.0g

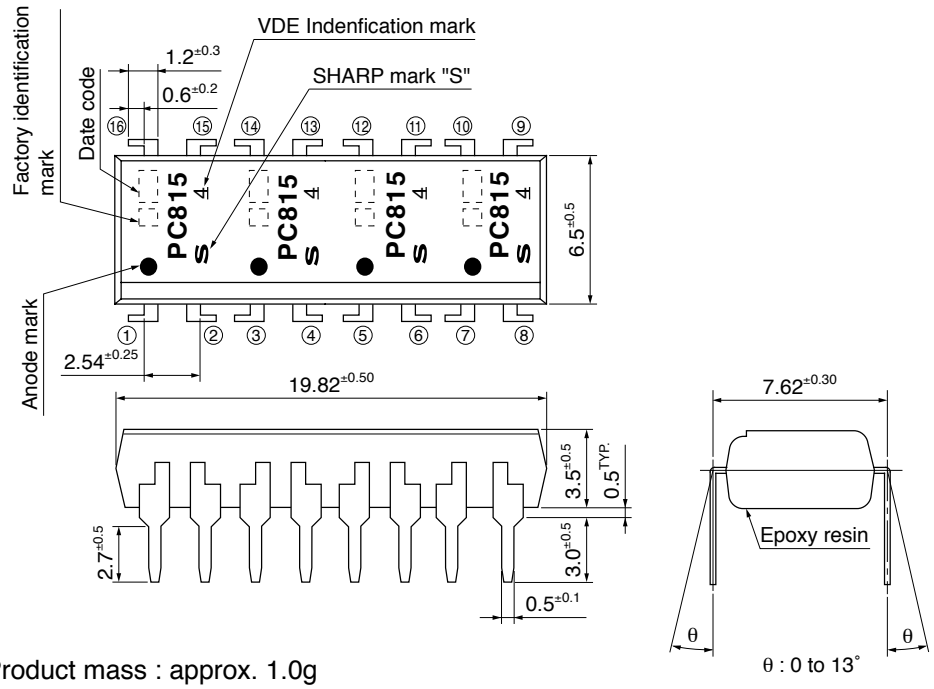
2. SMT Gullwing Lead-Form [ex. **PC845XIJ000F**]



Product mass : approx. 0.9g

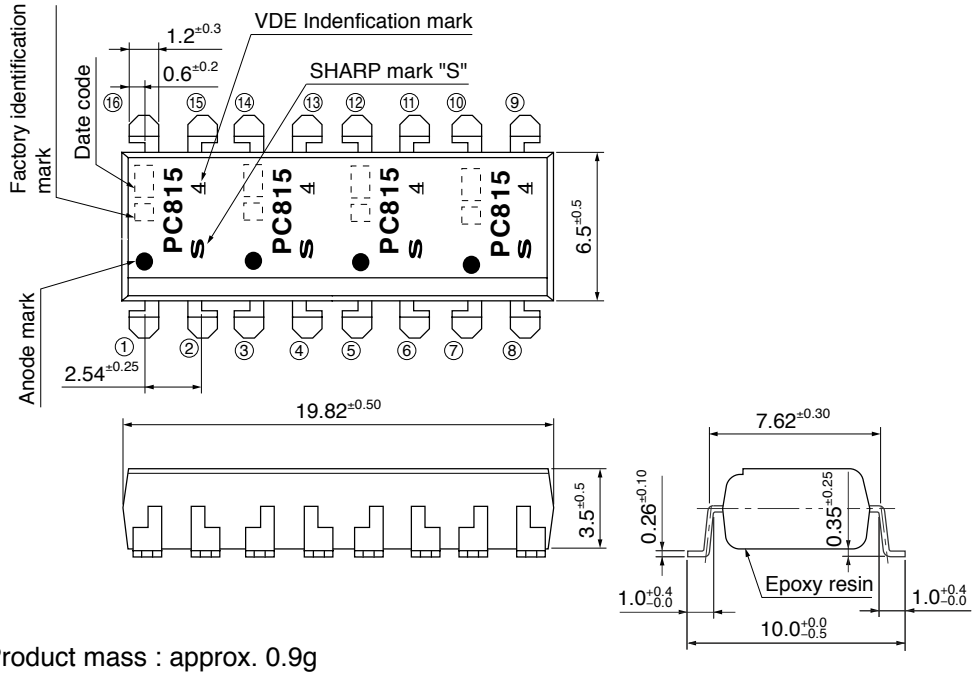
(Unit : mm)

3. Through-Hole (VDE option) [ex. **PC845XYJ000F**]



Product mass : approx. 1.0g

4. SMT Gullwing Lead-Form (VDE option) [ex. **PC845XIYJ00F**]



Product mass : approx. 0.9g

Plating material : SnCu (Cu : TYP. 2%)

Date code (2 digit)

1st digit				2nd digit	
Year of production				Month of production	
A.D.	Mark	A.D.	Mark	Month	Mark
1990	A	2002	P	January	1
1991	B	2003	R	February	2
1992	C	2004	S	March	3
1993	D	2005	T	April	4
1994	E	2006	U	May	5
1995	F	2007	V	June	6
1996	H	2008	W	July	7
1997	J	2009	X	August	8
1998	K	2010	A	September	9
1999	L	2011	B	October	O
2000	M	2012	C	November	N
2001	N	:	:	December	D

repeats in a 20 year cycle

Factory identification mark

Factory identification Mark	Country of origin
no mark	Japan
■	
◢	Indonesia
◥	China

* This factory marking is for identification purpose only.
Please contact the local SHARP sales representative to see the actural status of the production.

Rank mark

There is no rank mark indicator.

■ Absolute Maximum Ratings

(T_a=25°C)

Parameter		Symbol	Rating	Unit
Input	Forward current	I_F	50	mA
	*1 Peak forward current	I_{FM}	1	A
	Reverse voltage	V_R	6	V
	Power dissipation	P	70	mW
Output	Collector-emitter voltage	V_{CEO}	35	V
	Emitter-collector voltage	V_{ECO}	6	V
	Collector current	I_C	80	mA
	Collector power dissipation	P_C	150	mW
Total power dissipation		P_{tot}	200	mW
Operating temperature		T_{opr}	−30 to +100	°C
Storage temperature		T_{stg}	−55 to +125	°C
*2 Isolation voltage		$V_{iso(rms)}$	5	kV
*3 Soldering temperature		T_{sol}	270	°C

*1 Pulse width≤100ms, Duty ratio : 0.001
*2 40 to 60%RH, AC for 1minute, f=60Hz
*3 For 10s

■ Electro-optical Characteristics

(T_a=25°C)

Parameter			Symbol	Condition	MIN.	TYP.	MAX.	Unit
Input	Forward voltage		V_F	I_F=20mA	–	1.2	1.4	V
	Peak forward voltage		V_{FM}	I_{FM}=0.5V	–	–	3.0	V
	Reverse current		I_R	V_R=4V	–	–	10	μA
	Terminal capacitance		C_t	V=0, f=1kHz	–	30	250	pF
Output	Collector dark current		I_{CEO}	V_{CE}=10V, I_F=0	–	–	1 000	nA
	Collector-emitter breakdown voltage		BV_{CEO}	I_C=0.1mA, I_F=0	35	–	–	V
	Emitter-collector breakdown voltage		BV_{ECO}	I_E=10μA, I_F=0	6	–	–	V
Transfer characteristics	Current transfer ratio		I_C	I_F=1mA, V_{CE}=2V	6.0	16.0	75.0	mA
	Collector-emitter saturation voltage		$V_{CE(sat)}$	I_F=20mA, I_C=5mA	–	0.8	1.0	V
	Isolation resistance		R_{ISO}	DC500V, 40 to 60%RH	5×10^{10}	1×10^{11}	–	Ω
	Floating capacitance		C_f	V=0, f=1MHz	–	0.6	1.0	pF
	Cut-off frequency		f_C	V_{CE}=2V, I_C=2mA, R_L=100Ω, −3dB	1	6	–	kHz
	Response time	Rise time	t_r	V_{CE}=2V, I_C=10mA, R_L=100Ω	–	60	300	μs
		Fall time	t_f		–	53	250	μs

■ Model Line-up

Lead Form	Through-Hole		SMT Gullwing Form	
Package	Sleeve			
	25pcs/sleeve			
DIN EN60747-5-2	——	Approved	——	Approved
Model No.	**PC845XJ0000F**	**PC845XYJ000F**	**PC845XIJ000F**	**PC845XIYJ00F**

Please contact a local SHARP sales representative to inquire about production status.

Fig.1 Forward Current vs. Ambient Temperature

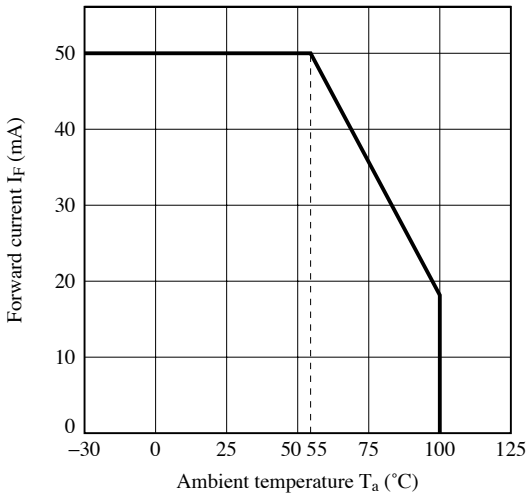


Fig.2 Diode Power Dissipation vs. Ambient Temperature

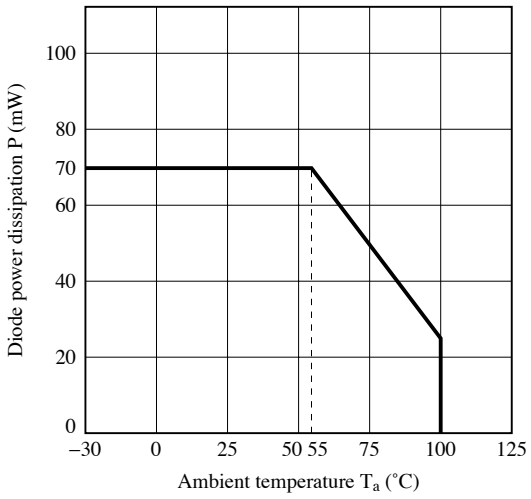


Fig.3 Collector Power Dissipation vs. Ambient Temperature

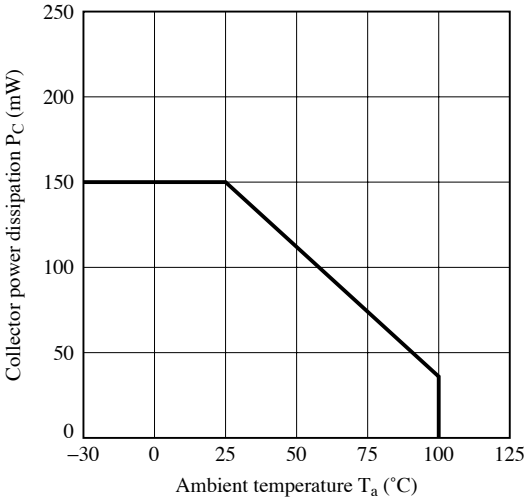


Fig.4 Total Power Dissipation vs. Ambient Temperature

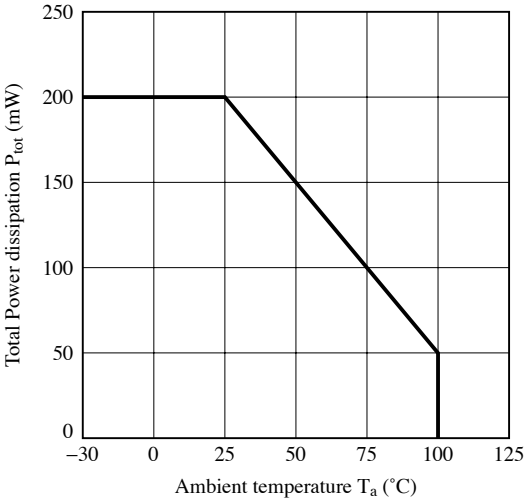


Fig.5 Peak Forward Current vs. Duty Ratio

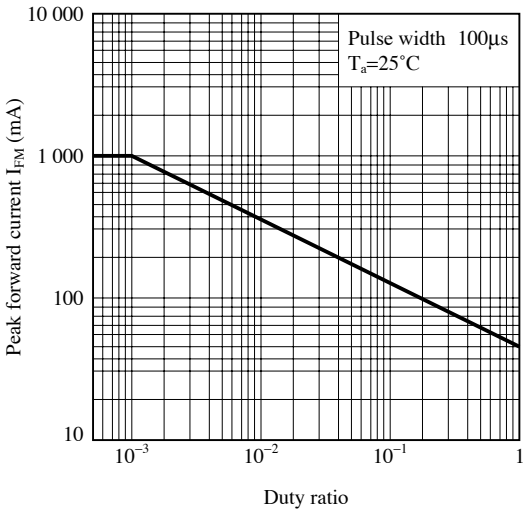


Fig.6 Current Transfer Ratio vs. Forward Current

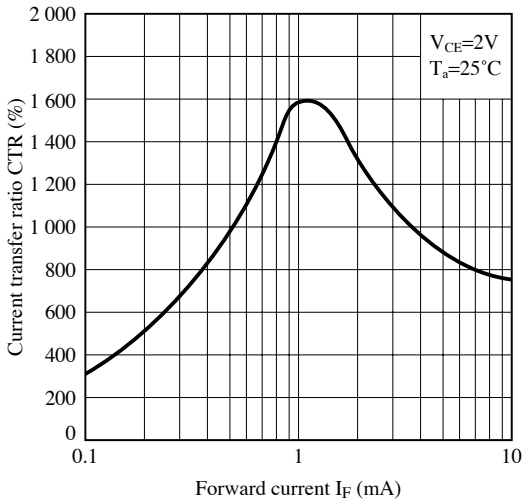


Fig.7 Forward Current vs. Forward Voltage

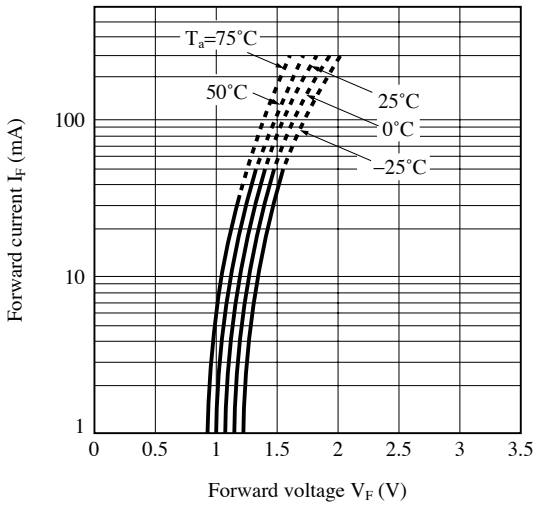


Fig.8 Collector Current vs. Collector-emitter Voltage

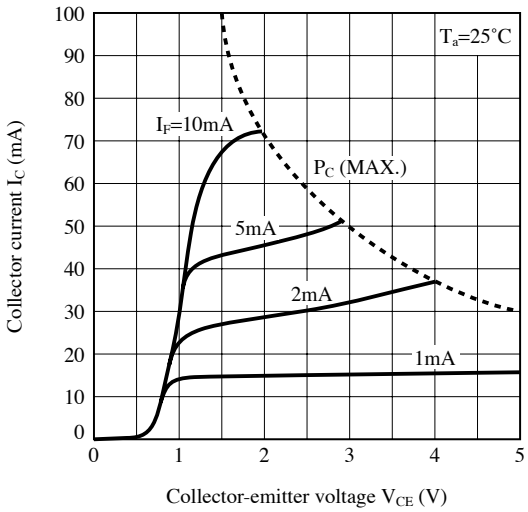


Fig.9 Relative Current Transfer Ratio vs. Ambient Temperature

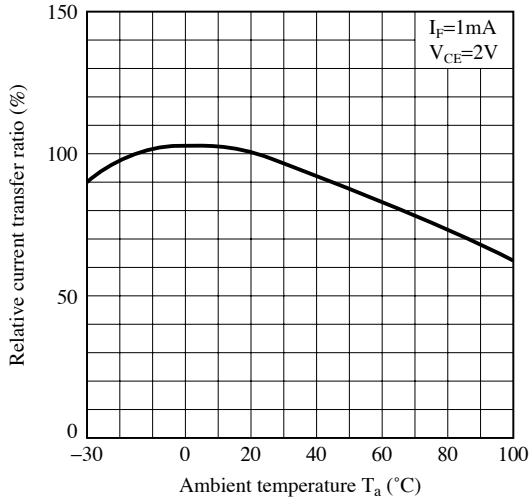


Fig.10 Collector - emitter Saturation Voltage vs. Ambient Temperature

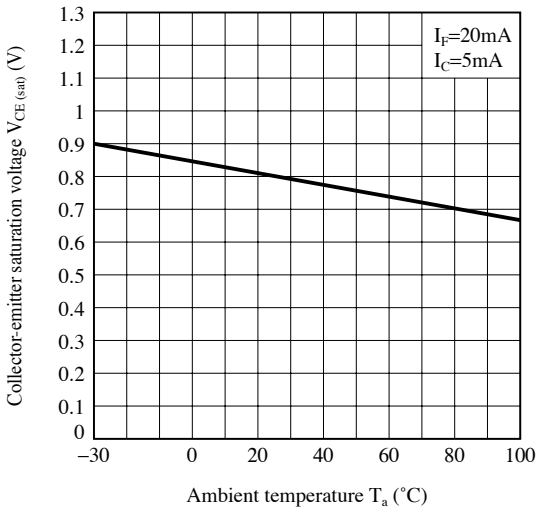


Fig.11 Collector Dark Current vs. Ambient Temperature

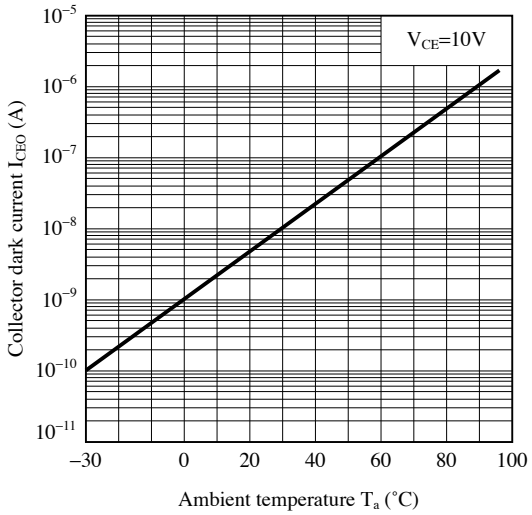


Fig.12 Collector-emitter Saturation Voltage vs. Forward Current

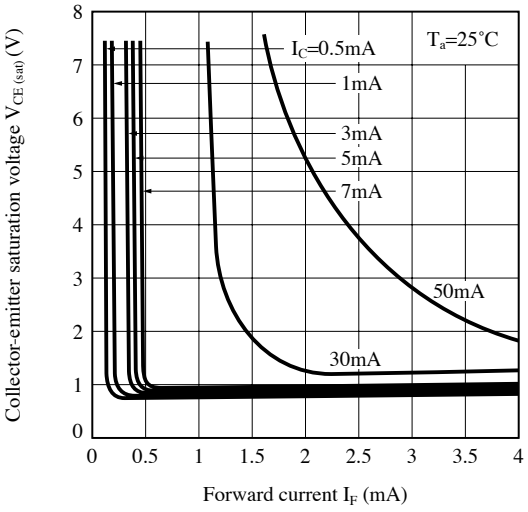


Fig.11 Response Time vs. Load Resistance

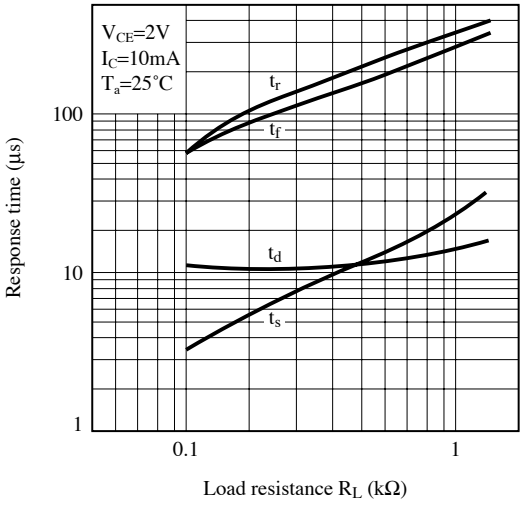
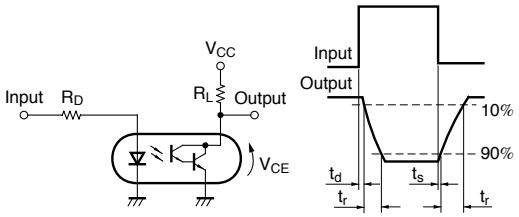


Fig.12 Test Circuit for Response Time



Please refer to the conditions in Fig.13

Fig.13 Frequency Response

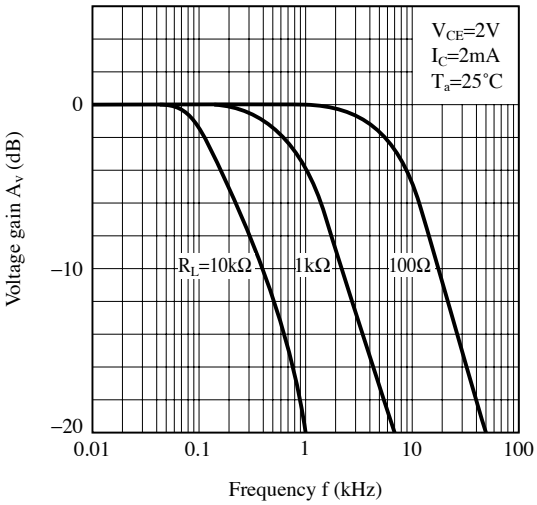
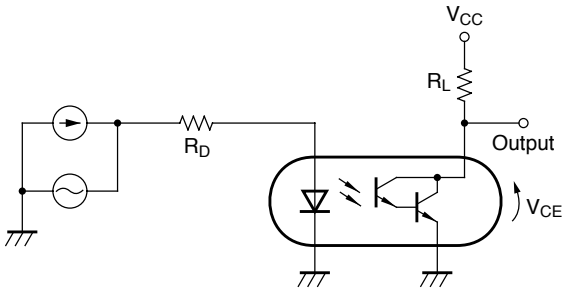


Fig.14 Test Circuit for Frequency Response



Please refer to the conditions in Fig.15

Remarks : Please be aware that all data in the graph are just for reference and not for guarantee.

■ Design Considerations

● Design guide

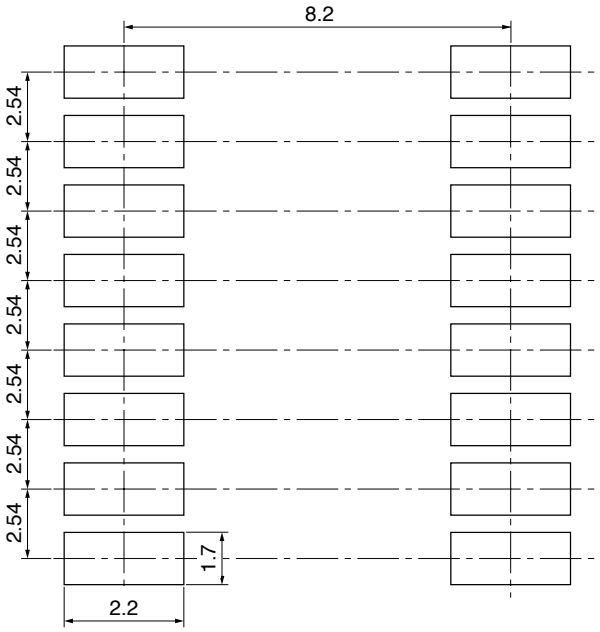
While operating at I_F<1.0mA, CTR variation may increase.
Please make design considering this fact.

This product is not designed against irradiation and incorporates non-coherent IRED.

● Degradation

In general, the emission of the IRED used in photocouplers will degrade over time.
In the case of long term operation, please take the general IRED degradation (50% degradation over 5 years) into the design consideration.

● Recommended foot print (reference)



(Unit : mm)

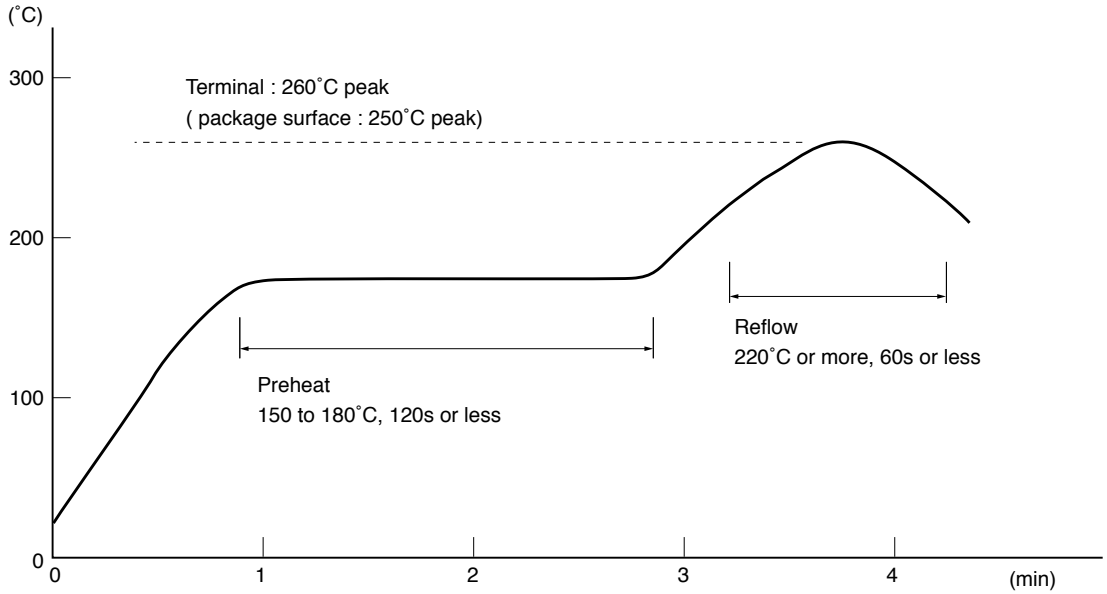
☆ For additional design assistance, please review our corresponding Optoelectronic Application Notes.

■ Manufacturing Guidelines

● Soldering Method

Reflow Soldering:

Reflow soldering should follow the temperature profile shown below.
Soldering should not exceed the curve of temperature profile and time.
Please don't solder more than twice.



Flow Soldering :

Due to SHARP's double transfer mold construction submersion in flow solder bath is allowed under the below listed guidelines.

Flow soldering should be completed below 270 ˚C and within 10s.
Preheating is within the bounds of 100 to 150 ˚C and 30 to 80s.
Please don't solder more than twice.

Hand soldering

Hand soldering should be completed within 3s when the point of solder iron is below 400 ˚C.
Please don't solder more than twice.

Other notice

Please test the soldering method in actual condition and make sure the soldering works fine, since the impact on the junction between the device and PCB varies depending on the tooling and soldering conditions.

● Cleaning instructions

Solvent cleaning :

Solvent temperature should be 45˚C or below. Immersion time should be 3 minutes or less.

Ultrasonic cleaning :

The impact on the device varies depending on the size of the cleaning bath, ultrasonic output, cleaning time, size of PCB and mounting method of the device.
Therefore, please make sure the device withstands the ultrasonic cleaning in actual conditions in advance of mass production.

Recommended solvent materials :

Ethyl alcohol, Methyl alcohol and Isopropyl alcohol.
In case the other type of solvent materials are intended to be used, please make sure they work fine in actual using conditions since some materials may erode the packaging resin.

● Presence of ODC

This product shall not contain the following materials.
And they are not used in the production process for this product.
Regulation substances : CFCs, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methylchloroform)

Specific brominated flame retardants such as the PBB and PBDE are not used in this product at all.

This product shall not contain the following materials banned in the RoHS Directive (2002/95/EC).

- Lead, Mercury, Cadmium, Hexavalent chromium, Polybrominated biphenyls (PBB), Polybrominated diphenyl ethers (PBDE).

■ Package specification

● Sleeve package

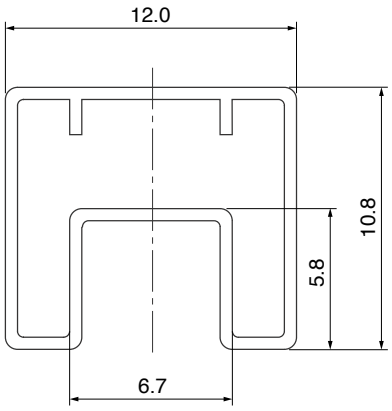
Package materials

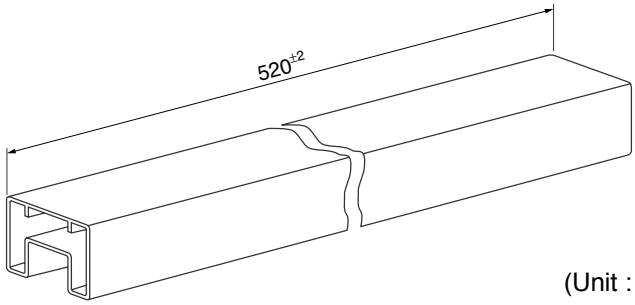
Sleeve : HIPS (with anti-static material)
Stopper : Styrene-Elastomer

Package method

MAX. 25 pcs. of products shall be packaged in a sleeve. Both ends shall be closed by tabbed and tabless stoppers.
The product shall be arranged in the sleeve with its anode mark on the tabless stopper side.
MAX. 20 sleeves in one case.

Sleeve outline dimensions





(Unit : mm)

■ Important Notices

· The circuit application examples in this publication are provided to explain representative applications of SHARP devices and are not intended to guarantee any circuit design or license any intellectual property rights. SHARP takes no responsibility for any problems related to any intellectual property right of a third party resulting from the use of SHARP's devices.

· Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device. SHARP reserves the right to make changes in the specifications, characteristics, data, materials, structure, and other contents described herein at any time without notice in order to improve design or reliability. Manufacturing locations are also subject to change without notice.

· Observe the following points when using any devices in this publication. SHARP takes no responsibility for damage caused by improper use of the devices which does not meet the conditions and absolute maximum ratings to be used specified in the relevant specification sheet nor meet the following conditions:

(i) The devices in this publication are designed for use in general electronic equipment designs such as:

--- Personal computers
--- Office automation equipment
--- Telecommunication equipment [terminal]
--- Test and measurement equipment
--- Industrial control
--- Audio visual equipment
--- Consumer electronics

(ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection with equipment that requires higher reliability such as:

--- Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
--- Traffic signals
--- Gas leakage sensor breakers
--- Alarm equipment
--- Various safety devices, etc.

(iii) SHARP devices shall not be used for or in connection with equipment that requires an extremely high level of reliability and safety such as:

--- Space applications
--- Telecommunication equipment [trunk lines]
--- Nuclear power control equipment
--- Medical and other life support equipment (e.g., scuba).

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· Contact and consult with a SHARP representative if there are any questions about the contents of this publication.